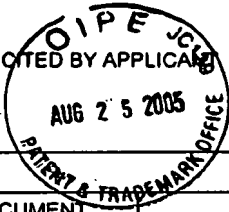
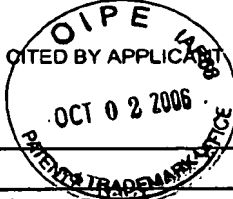


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 274136US0PCT		SERIAL NO. New U.S. PCT Application Based on PCT/JP03/16384	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroyuki YASHIMA, et al.		10/539801	
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
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	AM						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/PS/	AN	49-59186	06/08/74	JP		NO	
↓	AO	52-27494	03/01/77	JP		NO	
	AP	5-331440	12/14/93	JP		NO	
	AQ	7-90031	04/04/95	JP		NO	
	AR	11-158326	06/15/99	JP		NO	
	AS	52-992	01/06/77	JP		NO	
	AT	51-136773	11/26/76	JP		NO	
/PS/	AU	52-91050	08/01/77	JP		NO	
	AV	6-287360	10/11/94	JP		NO	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Peter Szekely/				Date Considered 10/23/2007			
Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 274136US0PCT		SERIAL NO. 10/539,801	
LIST OF REFERENCES CITED BY APPLICANT <div style="text-align: center; margin-top: 20px;">  </div>				APPLICANT Hiroyuki YASHIMA, et al.			
				FILING DATE June 20, 2005		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/PS/	AA	US 2005/0182173	08-18-05	YASHIMA ET AL.			
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
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	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner				/Peter Szekely/		Date Considered 10/23/2007	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
274136US0PCTSERIAL NO.
10/539,801

LIST OF REFERENCES CITED BY APPLICANT

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1714

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/PS/	AA	5,322,886	6/21/1994	Francois SAUTEREY			
	AB						
	AC						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
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/PS/	AO	1 529 495	10/18/1978	United Kingdom		
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	<input type="checkbox"/> Additional References sheet(s) attached

Examiner

/Peter Szekely/

Date Considered

10/23/2007

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 274136US0PCT		SERIAL NO. 10/539,801	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hiroyuki YASHIMA, et al.			
				FILING DATE June 20, 2005		GROUP 1714	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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FOREIGN PATENT DOCUMENTS							
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/PS/	AO	8-188694	07/23/1996	JAPAN		X	
↓	AP	8-269114	10/15/1996	JAPAN		X	
	AQ	9-12656	01/14/1997	JAPAN		X	
	AR	2002-53703	02/19/2002	JAPAN		X	
	AS	2002-53702	02/19/2002	JAPAN		X	
	/PS/	AT	2002-47377	02/12/2002	JAPAN		X
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner /Peter Szekely/					Date Considered 10/23/2007		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							